

Notice of References Cited

Application/Control No.

10/750,378

Applicant(s)/Patent Under
Reexamination
KOL ET AL.

Examiner

Van Kim T. Nguyen

Art Unit

2456

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2003/0236693	12-2003	Chen et al.	705/9
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